

**Total Intra Similarity And Dissimilarity Measure For The Values Taken By A Parameter Of Concern.** {Version 1}. ISSN 1751-3030

Author:

**Ramesh Chandra Bagadi**

*Data Scientist*

*INSOFE (International School Of Engineering),*

*Hyderabad, India.*

*rameshcbagadi@uwalumni.com*

*+91 9440032711*

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**Abstract**

In this research investigation, the author has detailed a novel method of finding the ‘*Total Intra Similarity And Dissimilarity Measure For The Values Taken By A Parameter Of Concern*’. The advantage of such a measure is that using this measure we can clearly distinguish the contribution of Intra aspect variation and Inter aspect variation when both are bound to occur in a given phenomenon of concern. This measure provides the same advantages as that provided by the popular F-Statistic measure.

**Theory**

Given any Sequence of the kind,

$S = \{y_1, y_2, y_3, \dots, y_{n-1}, y_n\}$  which represent the (ordered) values taken by a Parameter of concern. We first consider the Cartesian Cross Product of  $S$  with itself, i.e.

$R = S \times S = \prod_{i=1}^n \prod_{j=1}^n \{y_i, y_j\}$  where  $C$  denotes a Collection. We now consider elements of the kind  $\{y_i, y_j\}$  and  $\{y_j, y_i\}$  as same and therefore will consider only one among them in the sum terms shown below in the next line, which appears as

$$LB = \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j>i}^n \prod_{i=1}^n \{y_i, y_j\} \quad \text{Equation 1}$$

We now consider the smaller of each of the 2 tuple in the above set LB and add these values to give us

$$SLB = \sum \left\{ \text{Smaller} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \right\} \quad \text{Equation 2}$$

The spirit behind considering the smaller number is that it represents the congruence part of the two numbers. The logic behind removing the  $\prod_{j>i}^n \prod_{i=1}^n \{y_i, y_j\}$  terms is that when their congruence part is evaluated it is the same as their places juxtaposed counterparts of themselves in  $S \times S$ .

We now consider the larger of each of the 2 tuple in the above set LB (RHS of Equation 2) and add these values to give us

$$LLB = \sum \left\{ \text{Larger} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \right\} \quad \text{Equation 3}$$

Now, we call the Total Intra Similarity Measure as

$$AD = \frac{SLB}{LLB} = \frac{\sum \left\{ \text{Smaller} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \right\}}{\sum \left\{ \text{Larger} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \right\}} \quad \text{Equation 4}$$

The advantage of such a measure  $AD$  is that using this measure we can clearly distinguish the contribution of Intra aspect variation and Inter aspect variation (with respect to their similarity) when both are bound to occur in a given phenomenon of concern. This measure provides the same advantages as that provided by the popular F-Statistic measure.

Furthermore, we can even write the Total Intra Similarity Vector as

$$TISV = \sum_k \left\{ \text{Smaller} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \right\} \hat{e}_k \quad \text{Equation 5}$$

$$\text{where } k = n^2 - \binom{n^2 - n}{2} = \frac{n^2}{2} + \frac{n}{2}$$

We can use this Total Intra Similarity Vector to compare the Total Intra Similarity Measure of two Parameters that take the same number of values. Such a comparison can be achieved using any popular type of Inner Product scheme. These two Parameters could be different or could be the same Parameter whose observation is repeated again.

In a similar manner, we can define the Total Intra Dissimilarity Measure as

$$AD^- = \left( \frac{LLB - SLB}{LLB} \right) = \frac{\sum \left\{ \text{Larger} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} - \text{Smaller} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \right\}}{\sum \left\{ \text{Larger} \left\{ \prod_{i=1}^n \prod_{i=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \right\}} \quad \text{Equation 6}$$

The spirit behind considering the difference between the larger and smaller number is that it represents the non-congruence part of the two numbers.

The advantage of such a measure  $AD^-$  is that using this measure we can clearly distinguish the contribution of Intra aspect variation and Inter aspect variation (with respect to their dissimilarity) when both are bound to occur in a given phenomenon of concern. This measure provides the same advantages as that provided by the popular F-Statistic measure.

Furthermore, we can even write the Total Intra Dissimilarity Similarity Vector as

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[http://www.philica.com/display\\_article.php?article\\_id=1152](http://www.philica.com/display_article.php?article_id=1152)

$$TIDSV = \sum \left\{ \left[ \begin{array}{l} \text{Larger} \left\{ \prod_{i=1}^n \prod_{j=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \\ \text{Smaller} \left\{ \prod_{i=1}^n \prod_{j=1}^n \{y_i, y_j\} - \prod_{j:j>i}^n \prod_{i=1}^n \{y_i, y_j\} \right\} \end{array} \right] \right\} \hat{e}_k \text{ where}$$

$$k = n^2 - \left( \frac{n^2 - n}{2} \right) = \frac{n^2}{2} + \frac{n}{2} \text{ and the summation is over the } k \text{ terms.}$$

We can use this Total Intra Dissimilarity Vector to compare the Total Intra Dissimilarity Measure of two Parameters that take the same number of values. Such a comparison can be achieved using any popular type of Inner Product scheme. These two Parameters could be different or could be the same Parameter whose observation is repeated again.

## References

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